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Application/Control No.	Applicant(s)/Patent ur Reexamination	nder
10/720,074	LIN ET AL.	
Examiner	Art Unit	
JEAN B. FLEURANTIN	N 2162	

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10	4/25/2006	JBF
707	100-104.1	4/25/2006	JBF
707	200-206	4/25/2006	JBF
709	225	4/25/2006	JBF
713	152	4/25/2006	JBF
713	164	4/25/2006	JBF
713	166	4/25/2006	JBF
726	1-2	4/25/2006	JBF
726	12	4/25/2006	JBF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST (US PG PUB, US PT, EPO, JPO, DERWENT AND IBM TDB)	4/25/2006	JBF
707/CCLS AND 709/CCLS AND 713/CCLS AND 726/CCLS	4/25/2006	JBF
INVENTOR(S0 SEARCH AND REVIEWED ALL RELATED APPLICATION FOR POSSIBLE DOUBLE PATENTING	4/25/2006	JBF
CONSULTED - TQAS - 101 HELP PANEL M. BOOKDINDER	4/28/2006	JBF